Introduction to JTAG



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Boundary Scan JTAG Intro JTAG Architecture



- ► Allows you to debug individual IO pins of a chip in an assembled PCB (without physical access)
- ► Uses extra circuitary (called *wrapper*), one "test cell" attached to each pin
- ► These test cells provide a way to capture/update data
- ▶ All test cells are "daisy chained" (think a single big shift register)
- ► We essentially need a serial data i/p pin and an o/p pin to shift-in and shift-out bits from all the pins
- ► The *wrapper* lies dormant (invisible) during normal operation



Enter... JTAG!

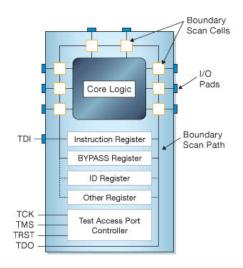
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- ▶ JTAG, the IEEE 1149.1 standard, was formalized
- ► Also called the boundary scan standard
- ▶ A standardized way to do boundary scan



- Originally that was its purpose, but it turned out to be much more versatile!
- ► Not just single chips, any number of chips can be debugged in a board (again, daisy chained)
- ▶ And not just the "boundary", interal system logic can also be debugged
- ► Further, can also be used for programming chips! (like FPGAs)







The JTAG port or Test Access Port (TAP) requires only 5 pins:

- ► TDI: Test Data Input (Serial Data in)
- ► TDO: Test Data Output (Serial Data out)
- ► TCK: Test Clock
- ► TMS: Test Mode Select (Change states in JTAG state machine)
- ► TRST: Test Reset (Optional, to reset JTAG state machine)

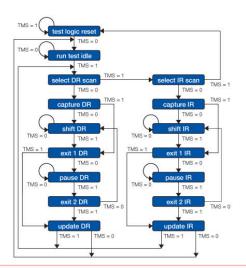


- ► Standard specifies one Instruction Register (IR) and various Data Registers (DR) to select from
- ► Mandatory Data registers:
 - ▶ Boundary Scan Register (BSR) the wrapper
 - ▶ Bypass Register (BYPASS) one bit register
- ▶ Optional Data Registers:
 - ▶ Device ID Register (IDCODE)
 - Various Device specific registers
- ► The register which is selected will shift-in bits from TDI and shift-out bits from TDO



- ► Contains the JTAG/TAP State Machine
- ▶ Also the Instruction Register and Instruction Decoder
- According to the current state in the state machine, one of the data register or instruction register will be selected/scanned/captured/updated
- Which data register is selected will depend on the instruction passed







- ► Mandatory instructions:
 - ▶ BYPASS (111...) Use BYPASS Register (Passthrough)
 - EXTEST (000...) Use BSR (Capture-DR -; Shift-DR -; Update-DR)
 - ► SAMPLE/PRELOAD Use BSR (when device in normal mode)
- Optional instructions:
 - ► IDCODE Use IDCODE register
 - ► INTEST Use BSR (test internal core-logic)
 - Various other design specific instructions

